


<b>Search Notes</b> 	<b>Application/Control No.</b> 10557820	<b>Applicant(s)/Patent Under Reexamination</b> HAN ET AL.
	<b>Examiner</b> Tran, Tony	<b>Art Unit</b> 2809

SEARCHED			
Class	Subclass	Date	Examiner
257	98-100	3/14/10	/TT/

SEARCH NOTES		
Search Notes	Date	Examiner
patent import from IDS	11/13/08	/TT/
Updated assignee search on EAST	04/20/09	/TT/
Updated full text search on EAST	3/14/10, 5/5/10	/TT/
IDS patent search, updated full text search on EAST	3/14/11	/TT/

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
	Interference search on EAST	3/14/11	/TT/

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